


<b>Search Notes</b> 	<b>Application/Control No.</b> 10520470	<b>Applicant(s)/Patent Under Reexamination</b> TUSCHL ET AL.
	<b>Examiner</b> Shin, Dana	<b>Art Unit</b> 1635

SEARCHED			
Class	Subclass	Date	Examiner
514	44	6-13-07	DS
536	24.5	6-13-07	DS
435	6, 375	6-13-07	DS

SEARCH NOTES		
Search Notes	Date	Examiner
EAST - search strategy attached	6-13-07	DS
Medline, Biosis, Embase, Scisearch, CA - search strategy attached	6-13-07	DS
PALM - inventor name search	6-13-07	DS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner